

# *SCAs against Embedded Crypto Devices*

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Lecture 2 - Side-Channel Attacks (I)



# Outline

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- ▶ Introduction
- ▶ Basics of Side-Channel Attacks
  - ▶ Origin of the leakages
  - ▶ Measurement setups
  - ▶ SPA, DPA
- ▶ Exemplary attack against the DES
- ▶ Improved attacks
- ▶ Countermeasures
- ▶ Key independence and asymptotic equivalences



# Cryptographic devices



# *Attacks against cryptographic devices*

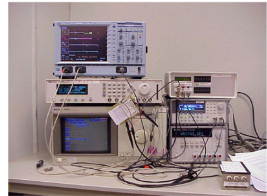
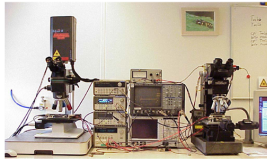
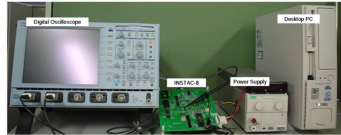
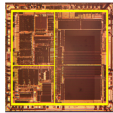
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- ▶ Classical (or Black box) cryptanalysis: only uses the cryptographic primitives inputs and outputs, e.g the plaintexts, ciphertexts for block ciphers
- ▶ Physical attacks: additionally take advantage of physical specificities in the implementations
  - ▶ Probing attacks
  - ▶ Side-channel attacks
  - ▶ Fault insertion attacks
  - ▶ ...





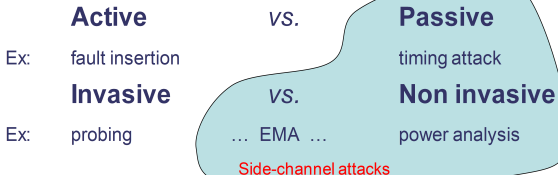
# Physical attacks



# Classification of physical attacks

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- ▶ According to the type of attack



- ▶ According to the strength of the adversary: common criteria, FIPS 140-2, IBM taxonomy, ...



# Side-channel attacks

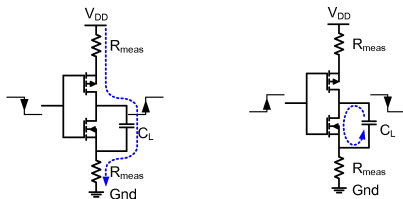
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- ▶ Take advantage of physical leakages such as timing information (1996), power consumption (1998), electromagnetic radiation (2001), cache hits/misses (2005), branch predictions (2006), ...
- ▶ Continuous problem: there is a “certain” amount of information that is leaked  $\Rightarrow$  difficult to model
- ▶ By contrast probing and fault attacks are discrete problems: a wire can/cannot be read, a fault can/cannot be inserted  $\Rightarrow$  easier to model



# Origin of the leakages

- ▶ e.g. Dynamic power consumption in CMOS devices



$$P_{dyn} \propto C_L \cdot V_{DD}^2 \cdot f_{op} \cdot P_{0 \rightarrow 1}$$

- ▶  $P_{0 \rightarrow 1} \Rightarrow$  data dependent physical leakage
- ▶ But  $\nRightarrow P_{dyn}$  is the only source of information



# Origin of the leakages

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- ▶ e.g. EM radiation in CMOS devices

$$d\mathbf{B} = \frac{\mu_0 I d\mathbf{l} \times \hat{\mathbf{r}}}{4\pi r^2}$$

- ▶ Data dependent current intensity
  - ▶ As for the power consumption
- ▶ Field orientation depends on the current direction



# Measurement setups

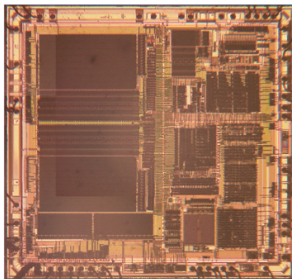
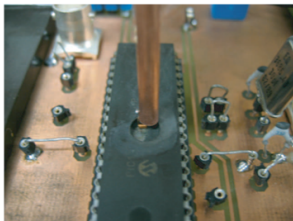
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- ▶ Target device: smart card ASIC, FPGA, ...
- ▶ Measurement circuit: resistor inserted in supply circuit, small antenna (hand made coil), ...
- ▶ Digital oscilloscope (1 Gsample/s)



# Measurement setups

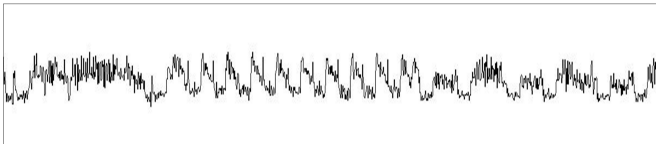
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# SPA

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- ▶ Operation dependent leakage variations
- ▶ Example: AES encryption, 10 rounds



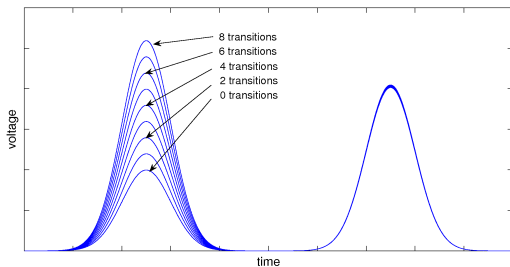
- ▶ Not an attack in itself for block ciphers
  - ▶ Preliminary step before other attacks
- ▶ May be very powerful (e.g. public key cryptography)





# DPA

- ▶ Data dependent leakage variations

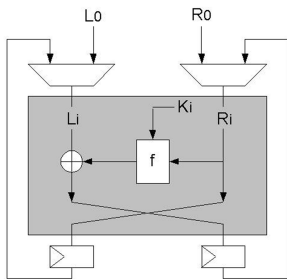


- ▶ e.g. CMOS: power consumption dependent on the number of bit switches within the target device

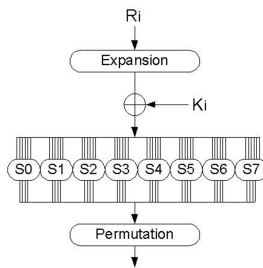


# Exemplary attack against the DES

- ▶ The Data Encryption Standard
- ▶ FPGA implementation, loop architecture



(a) DES

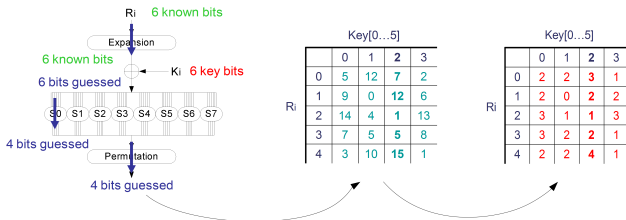


(b) f function



# Exemplary attack against the DES

1. Input selection: random plaintexts
2. Internal values derivation
3. Leakage modeling (Hamming weights)



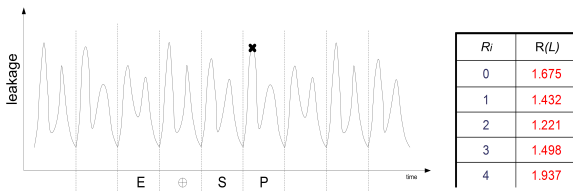
► How to avoid any physical attack? {...}



# Exemplary attack against the DES

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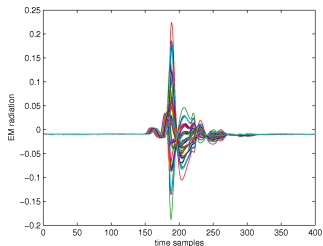
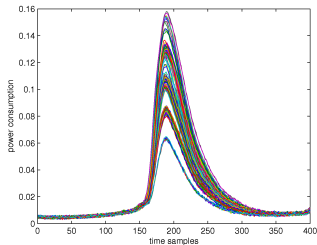
4. Leakage measurement
5. Leakage reduction (select representative samples)



# Exemplary attack against the DES

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- ▶ In practice, power consumption vs. EM radiation



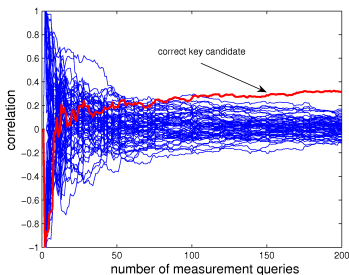
# Exemplary attack against the DES

## 6. Statistical test

- ▶ e.g. correlation coefficient

Key[0...5]	0	1	2	3
corr	-0.09	0.05	0.3	-0.11

$$\text{corr}(M, L) = \frac{\sum_{m \in \mathcal{M}, l \in \mathcal{L}} (m - \bar{M}) \cdot (l - \bar{L})}{\sqrt{\sum_{m \in \mathcal{M}} (m - \bar{M})^2 \cdot \sum_{l \in \mathcal{L}} (l - \bar{L})^2}}$$



- ▶ How to recover other bits of the master key? {...}



# Example

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▶ { ... }



# *Improved attacks*

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# *Improved attacks*

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- ▶ Improved measurement setups
  - ▶ Or combine different channels (e.g. power, EM)
- ▶ Adaptive selection of the inputs
- ▶ Pre-processing of the traces (e.g. averaging, filtering)
- ▶ Improved leakage models by profiling, characterization
- ▶ Exploitation of multiple samples, multivariate statistics
  - ▶ Higher-order attacks
  - ▶ Template attacks
- ▶ Different statistical tests
  - ▶ Difference of mean
  - ▶ Correlation analysis
  - ▶ Bayesian classification



# *Improved attacks*

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- ▶ Example: univariate template attack
  - ▶ Optimal statistical test
  - ▶ Profiled leakage model
  - ▶ Most powerful type of attack
  - ▶ (specially when extended to the multivariate case)
- ▶ Mainly identical to the previous attack
  - ▶ Only 3 steps vary...



# Improved attacks

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## 0. Preparation of the leakage model

- ▶ Assume Gaussian noise:

$$\mathcal{N}(R(l_i)|\mu_{v_i}, \sigma_{v_i}) = \frac{1}{\sigma_{v_i}\sqrt{2\pi}} \exp\frac{-(R(l_i) - \mu_{v_i})^2}{2\sigma_{v_i}^2}$$

- ▶ Estimate the means  $\mu_{v_i}$ 's and variances  $\sigma_{v_i}$ 's for each intermediate value  $v_i$  from  $N_t$  leakage traces

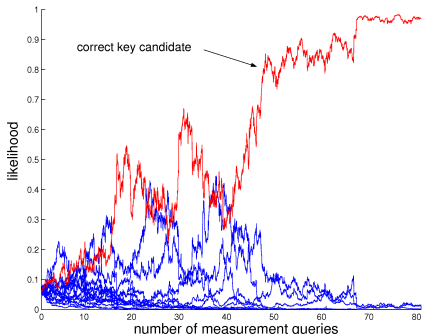
## 3. Leakage modeling: $\hat{P}_r[R(l_i)|v_i] = \mathcal{N}(R(l_i)|\hat{\mu}_{v_i}, \hat{\sigma}_{v_i})$

- ▶ In place of Hamming weights



# Improved attacks

6. Statistical test:  $\tilde{k} = \underset{k^*}{\operatorname{argmax}} \prod_{i=1}^q \hat{\Pr}[R(l_i) | x_i, k^*]$



# Countermeasures

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# Countermeasures

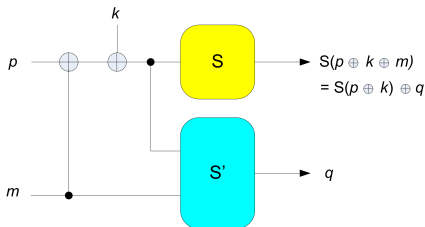
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- ▶ Never perfect (only make the attack harder)
- ▶ Can be implemented at different abstraction levels:
  - ▶ Physical (e.g. noise addition, decoupling C)
  - ▶ Technological (e.g. dual-rail logic styles)
  - ▶ HW/SW design (e.g. time/data randomization)
  - ▶ Algorithmic/protocol (e.g. key updates)
- ▶ To balance with implementation cost!
- ▶ Next: two typical examples



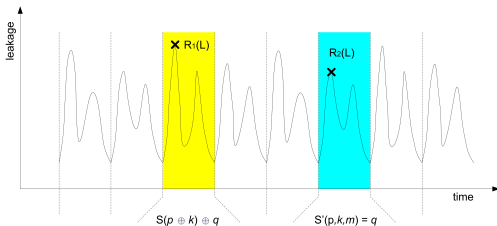
# Countermeasure 1: masking

- ▶ Goal: have data-independent leakage
- ▶ How: by “randomizing” the computation
- ▶ e.g. block cipher S-box



# Countermeasure 1: masking

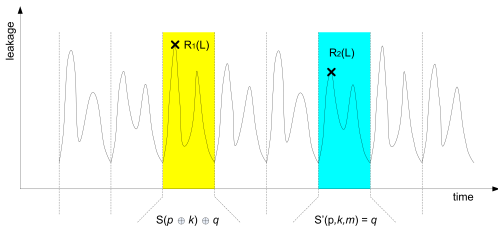
- ▶  $R_1(L) \perp k, R_2(L) \perp k$





# Countermeasure 1: masking

- ▶  $R_1(L) \perp k, R_2(L) \perp k$

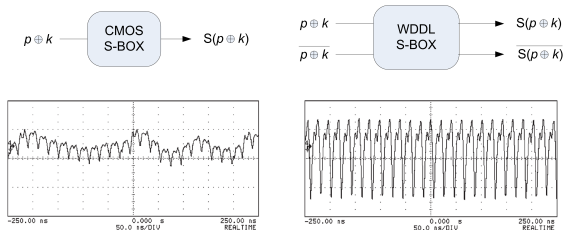


- ▶ But  $\exists f$  such that  $f(R_1(L), R_2(L)) \propto k$ 
  - ▶ Univariate  $\rightarrow$  bivariate
  - ▶ The rest of the attack remains unchanged



## Countermeasure 2: dual-rails

- ▶ Goal: have data-independent leakage
- ▶ How: by forcing constant leakage
- ▶ e.g. WDDL logic style



## Countermeasure 2: *dual-rails*

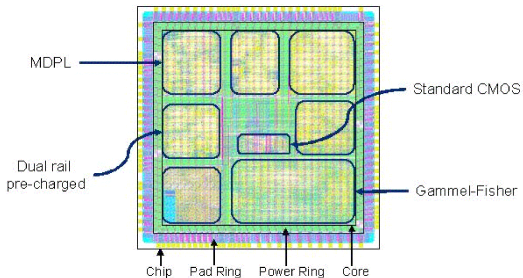
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- ▶ Hamming weight/distance models seem meaningless
- ▶ But  $\exists$  data dependent leakage variations
- ▶  $\exists f$  such that  $R(L) \propto f(p, k)$
- ▶ An efficient attack may require to
  - ▶ Change the leakage model
    - ▶ But possibly involves a  $\neq$  adversarial context
  - ▶ Use device-independent attacks



# Countermeasures: cost

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# *Key independence*

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- ▶ {...}
- ▶ Under the assumptions that:



# Key independence

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- ▶ {...}
- ▶ Under the assumptions that:
  - ▶ Plaintexts are uniformly distributed
  - ▶  $L_t(x_i, k) = f(x_i \oplus k) \neq f(x_i, k)$



# *Asymptotic equivalences*

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- ▶ {...}
- ▶ Under the additional assumption that:



# Asymptotic equivalences

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- ▶ {...}
- ▶ Under the additional assumption that:
  - ▶  $L_t(x_i, k) = \delta(x_i, k) + n$ ,
  - ▶ with  $n$  normally distributed, identical  $\forall t$ 's and independent of the data manipulated
  - ▶ The same models are used by all distinguishers





# Summary

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- ▶ Practical attacks (against real world devices)
- ▶ Device specific  $\Rightarrow$  less generic but usually more powerful than black box attacks
- ▶  $\exists$  a wide variety of statistical tools, leakage models, ...
- ▶ Key independence can make evaluations easier
- ▶ Distinguishers can asymptotically equivalent in certain contexts (e.g. “standard univariate DPA”)
- ▶ Attacks can be sophisticated, combined with other (computational) cryptanalytic techniques



# Thanks

